# MT3206

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### **MT3206 60V N-Channel MOSFET**

#### **General Description**

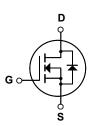
These N-Channel enhancement mode power field effect transistors ar e produced using Mos-tech's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially t ailored to minimize on-st ate resist ance, provide superior swit ching performance, and wit hstand high energy pulse in t he avalanche and commutation mode. These devices are well suited for low voltage applications such as automotive, DC/ DC conver ters, and high ef ficiency swit ching f or power management in portable and battery operated products.

#### Features

- \* 50A, 60V,  ${\rm R}_{\rm DS(on)}$  = 0.01 $\Omega$  @V\_{\rm GS} = 10 V \* Low gate charge ( typical 43 nC)
- Low Crss (typical 85 pF) •
- Fast switching
- · 100% avalanche tested
- Improved dv/dt capability
- 175°C maximum junction temperature rating





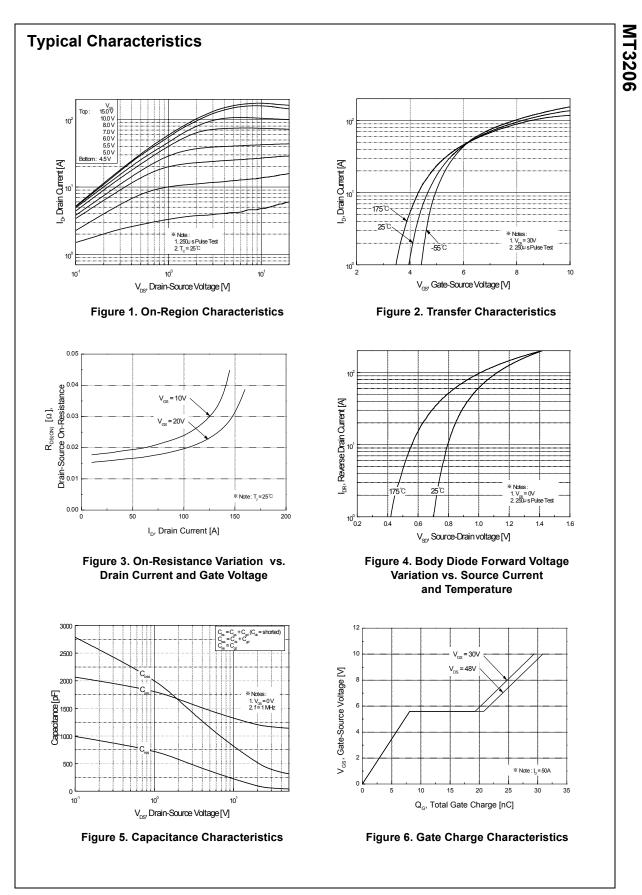
#### Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

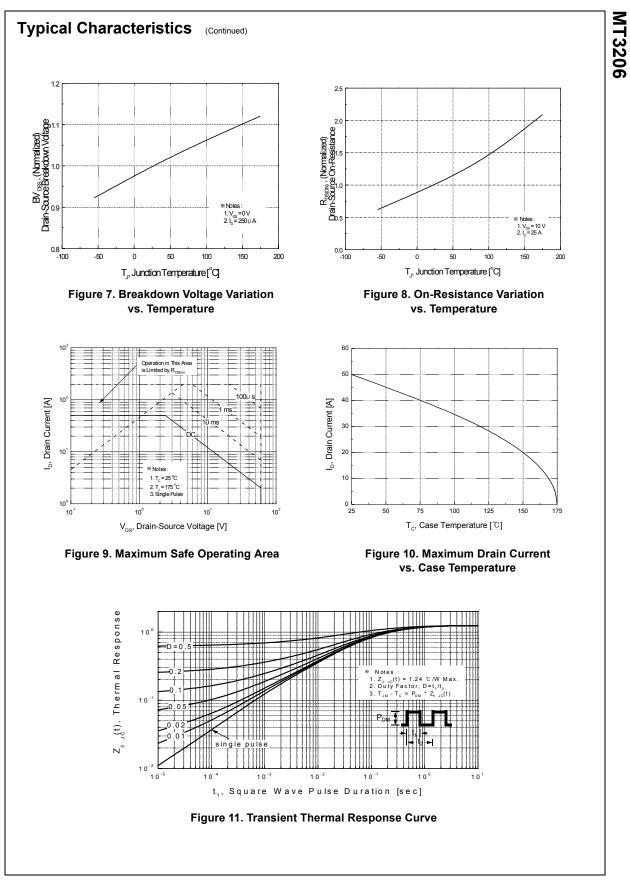
Symbol	Parameter		MT3206	Units
V <sub>DSS</sub>	Drain-Source Voltage		60	V
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°	C)	50	A
	- Continuous (T <sub>C</sub> = 100°C)		28	А
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	180	А
V <sub>GSS</sub>	Gate-Source Voltage		± 25	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy	(Note 2)	420	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	40	А
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	10	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	6.0	V/ns
PD	Power Dissipation ( $T_C = 25^{\circ}C$ )		100	W
	- Derate above 25°C		0.9	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +175	°C
ΤL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

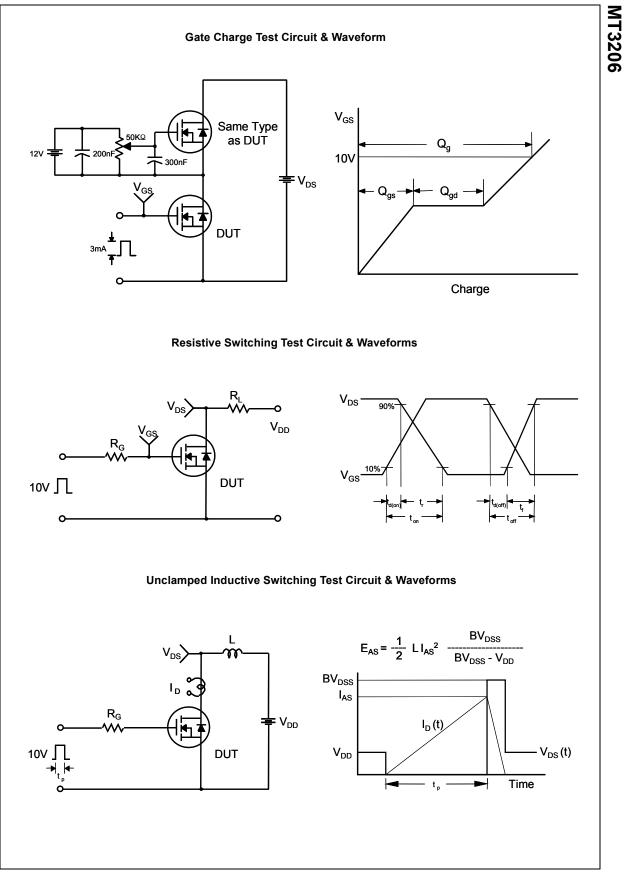
#### **Thermal Characteristics**

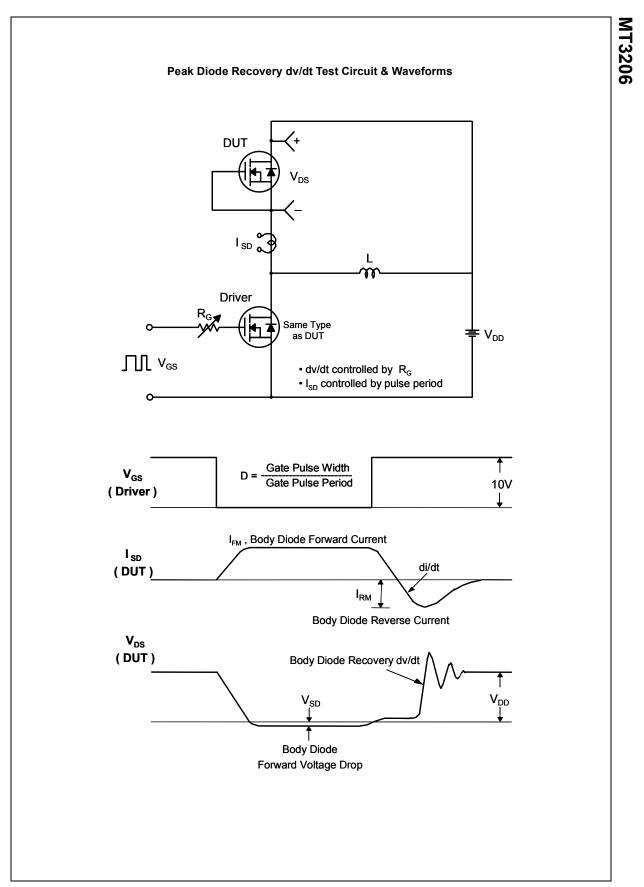
Symbol	Parameter	Тур	Max	Units
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction-to-Case		1.64	°C/W
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink	0.7		°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		65.5	°C/W

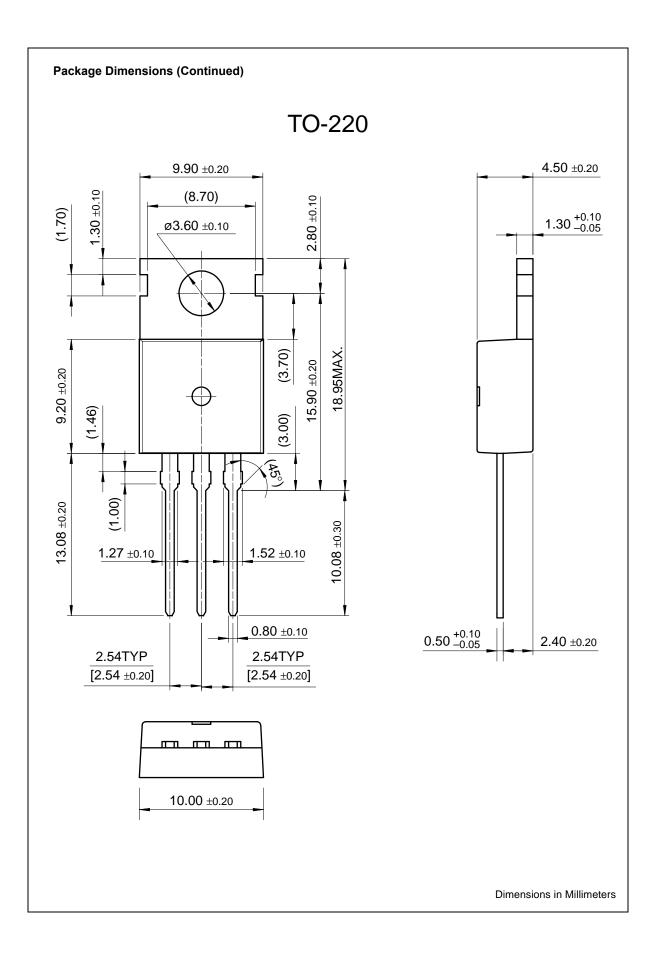
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	aracteristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	60			V
$\Delta BV_{DSS}$	Breakdown Voltage Temperature	$I_D = 250 \mu\text{A}$ , Referenced to 25°C		0.06		
/ $\Delta T_J$	Coefficient			0.06		V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0 V			1	μA
		V <sub>DS</sub> = 48 V, T <sub>C</sub> = 150°C			10	μA
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = 25 V, V <sub>DS</sub> = 0 V			100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	$V_{GS}$ = -25 V, $V_{DS}$ = 0 V			-100	nA
On Cha	aracteristics					
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0	2.7	4.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10 VI <sub>D</sub> = 25 A		0.009	0.01	Ω
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 25 V, I <sub>D</sub> = 25 A (Note 4)		20		S
Cico	Input Capacitance			1380	1600	pF
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub> Q <sub>g</sub>	Output Capacitance Reverse Transfer Capacitance ing Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz $V_{DD} = 30 \text{ V}, I_D = 25 \text{ A},$ R <sub>G</sub> = 25 $\Omega$ (Note 4, 5) $V_{DS} = 48 \text{ V}, I_D = 50 \text{ A},$	    	490 85 18 135 60 65 31	590 90 45 270 130 140 41	ns ns ns nC
$\frac{C_{oss}}{C_{rss}}$ Switch $\frac{t_{d(on)}}{t_r}$ $\frac{t_{d(off)}}{t_f}$ $Q_g$ $Q_{gs}$	Output Capacitance Reverse Transfer Capacitance ing Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge	f = 1.0 MHz $V_{DD} = 30 \text{ V}, \text{ I}_D = 25 \text{ A},$ $R_G = 25 \Omega$ (Note 4, 5) $V_{DS} = 48 \text{ V}, \text{ I}_D = 50 \text{ A},$ $V_{GS} = 10 \text{ V}$	   	85 18 135 60 65 31 8	90 45 270 130 140	pF ns ns ns nC nC
$\begin{array}{c} C_{oss} \\ \hline C_{rss} \end{array}$	Output Capacitance Reverse Transfer Capacitance ing Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge	f = 1.0 MHz $V_{DD} = 30 \text{ V}, \text{ I}_{D} = 25 \text{ A},$ $R_{G} = 25 \Omega$ (Note 4, 5) $V_{DS} = 48 \text{ V}, \text{ I}_{D} = 50 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note 4, 5)	   	85 18 135 60 65 31	90 45 270 130 140	pF ns ns ns nC
$\begin{array}{c} C_{oss} \\ \hline C_{rss} \end{array}$	Output Capacitance         Reverse Transfer Capacitance         ing Characteristics         Turn-On Delay Time         Turn-On Rise Time         Turn-Off Delay Time         Turn-Off Fall Time         Total Gate Charge         Gate-Source Charge         Gate-Drain Charge	$f = 1.0 \text{ MHz}$ $V_{DD} = 30 \text{ V}, \text{ I}_{D} = 25 \text{ A},$ $R_{G} = 25 \Omega$ (Note 4, 5) $V_{DS} = 48 \text{ V}, \text{ I}_{D} = 50 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note 4, 5) (Note 4, 5)	   	85 18 135 60 65 31 8	90 45 270 130 140	pF ns ns ns nC nC
$\frac{C_{oss}}{C_{rss}}$ Switch $\frac{t_{d(on)}}{t_r}$ $\frac{t_{d(off)}}{t_f}$ $\frac{Q_g}{Q_{gs}}$ $Q_{gd}$ Drain-S	Output Capacitance         Reverse Transfer Capacitance         ing Characteristics         Turn-On Delay Time         Turn-On Rise Time         Turn-Off Delay Time         Turn-Off Fall Time         Total Gate Charge         Gate-Source Charge         Gate-Drain Charge         Source Diode Characteristics and the second seco	f = 1.0 MHz $V_{DD} = 30 \text{ V}, \text{ I}_{D} = 25 \text{ A},$ $R_{G} = 25 \Omega$ (Note 4, 5) $V_{DS} = 48 \text{ V}, \text{ I}_{D} = 50 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note 4, 5) <b>nd Maximum Ratings</b> ode Forward Current		85 18 135 60 65 31 8 13	90 45 270 130 140 41 	pF ns ns nC nC nC
$\frac{C_{oss}}{C_{rss}}$ $\frac{Switch}{t_{d(on)}}$ $t_r$ $\frac{t_{d(off)}}{t_f}$ $Q_g$ $Q_{gs}$ $Q_{gd}$ $Drain-S$ $I_S$	Output Capacitance         Reverse Transfer Capacitance         ing Characteristics         Turn-On Delay Time         Turn-On Rise Time         Turn-Off Delay Time         Turn-Off Fall Time         Total Gate Charge         Gate-Source Charge         Gate-Drain Charge         Source Diode Characteristics an         Maximum Continuous Drain-Source Diode	f = 1.0 MHz $V_{DD} = 30 \text{ V}, \text{ I}_{D} = 25 \text{ A},$ $R_{G} = 25 \Omega$ (Note 4, 5) $V_{DS} = 48 \text{ V}, \text{ I}_{D} = 50 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note 4, 5) <b>nd Maximum Ratings</b> ode Forward Current	         	85 18 135 60 65 31 8 13	90 45 270 130 140 41   50	pF ns ns nC nC nC
$\begin{array}{c} C_{oss} \\ \hline C_{rss} \\ \hline \end{array} \\ \hline \begin{array}{c} \textbf{Switch} \\ t_{d(on)} \\ t_{r} \\ t_{d(off)} \\ t_{f} \\ \hline \\ Q_{g} \\ \hline \\ Q_{gs} \\ \hline \\ Q_{gd} \\ \hline \\ $	Output Capacitance Reverse Transfer Capacitance ing Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Source Diode Characteristics an Maximum Continuous Drain-Source Diode F	$f = 1.0 \text{ MHz}$ $V_{DD} = 30 \text{ V}, \text{ I}_{D} = 25 \text{ A},$ $R_{G} = 25 \Omega$ $(Note 4, 5)$ $V_{DS} = 48 \text{ V}, \text{ I}_{D} = 50 \text{ A},$ $V_{GS} = 10 \text{ V}$ $(Note 4, 5)$ $Note 4, 5)$ $Note 4, 5)$ $Note 4 \text{ Current}$ $Note 4 \text{ Current}$	          	85 18 135 60 65 31 8 13  	90 45 270 130 140 41   50 170	pF ns ns nC nC nC A A













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